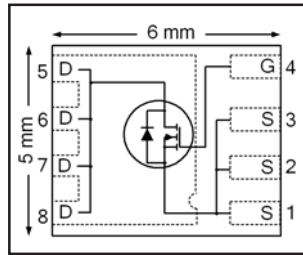


**Applications**

- Brushed Motor drive applications
- BLDC Motor drive applications
- PWM Inverterized topologies
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Electronic ballast applications
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters



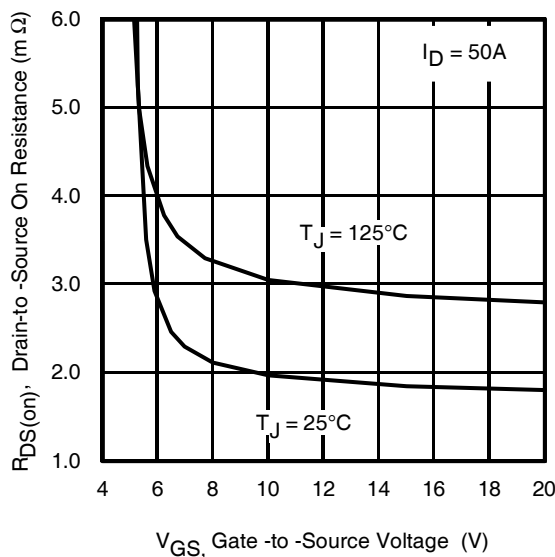
<b>V<sub>DS</sub></b>	<b>40V</b>
<b>R<sub>DS(on)</sub> typ. max.</b>	<b>1.8mΩ</b> <b>2.4mΩ</b>
<b>I<sub>D</sub> (Silicon Limited)</b>	<b>159A</b> Ⓢ
<b>I<sub>D</sub> (Package Limited)</b>	<b>85A</b>

**Benefits**

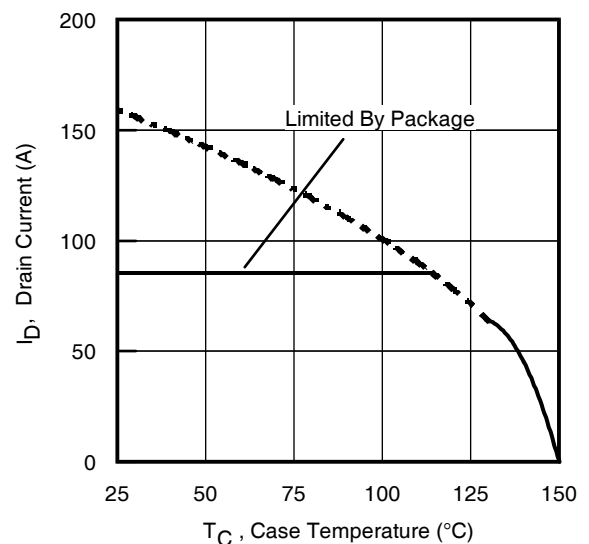
- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- RoHS Compliant containing no Lead, no Bromide, and no Halogen



Base Part Number	Package Type	Standard Pack		Orderable Part Number	Note
		Form	Quantity		
MS7440PBF	PQFN 5mm x 6mm	Tape and Reel	4000	MS7440TRPBF	EOL notice #259



**Fig 1.** Typical On-Resistance vs. Gate Voltage



**Fig 2.** Maximum Drain Current vs. Case Temperature

**Absolute Maximum Ratings**

Symbol	Parameter	Max.	Units
$I_D @ T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$ (Silicon Limited)	159 <sup>①</sup>	A
$I_D @ T_C = 100^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$ (Silicon Limited)	101 <sup>①</sup>	
$I_D @ T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$ (Package Limited)	85	
$I_{DM}$	Pulsed Drain Current <sup>②</sup>	624	
$P_D @ T_C = 25^\circ\text{C}$	Maximum Power Dissipation	104	W
	Linear Derating Factor	0.83	W/ $^\circ\text{C}$
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
dv/dt	Peak Diode Recovery <sup>④</sup>	3.0	V/ns
$T_J$	Operating Junction and	-55 to + 150	$^\circ\text{C}$
$T_{STG}$	Storage Temperature Range		

**Avalanche Characteristics**

$E_{AS}$ (Thermally limited)	Single Pulse Avalanche Energy <sup>③</sup>	121	mJ
$E_{AS}$ (Thermally limited)	Single Pulse Avalanche Energy <sup>⑩</sup>	232	
$I_{AR}$	Avalanche Current <sup>②</sup>	See Fig. 14, 15, 22a, 22b	A
$E_{AR}$	Repetitive Avalanche Energy <sup>②</sup>		mJ

**Thermal Resistance**

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$ (Bottom)	Junction-to-Case <sup>⑥</sup>	—	1.2	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$ (Top)	Junction-to-Case <sup>⑥</sup>	—	31	
$R_{\theta JA}$	Junction-to-Ambient <sup>⑥</sup>	—	35	
$R_{\theta JA} (<10\text{s})$	Junction-to-Ambient <sup>⑥</sup>	—	22	

**Static @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40	—	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.031	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1.0\text{mA}$ <sup>②</sup>
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	1.8	2.4	m $\Omega$	$V_{GS} = 10\text{V}, I_D = 50\text{A}$ <sup>⑤</sup>
		—	2.7	—	m $\Omega$	$V_{GS} = 6.0\text{V}, I_D = 25\text{A}$ <sup>⑤</sup>
$V_{GS(th)}$	Gate Threshold Voltage	2.2	—	3.9	V	$V_{DS} = V_{GS}, I_D = 100\mu\text{A}$
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	1.0	$\mu\text{A}$	$V_{DS} = 40\text{V}, V_{GS} = 0\text{V}$
		—	—	150		$V_{DS} = 40\text{V}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20\text{V}$
$R_G$	Internal Gate Resistance	—	2.6	—	$\Omega$	

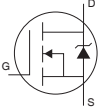
**Notes:**

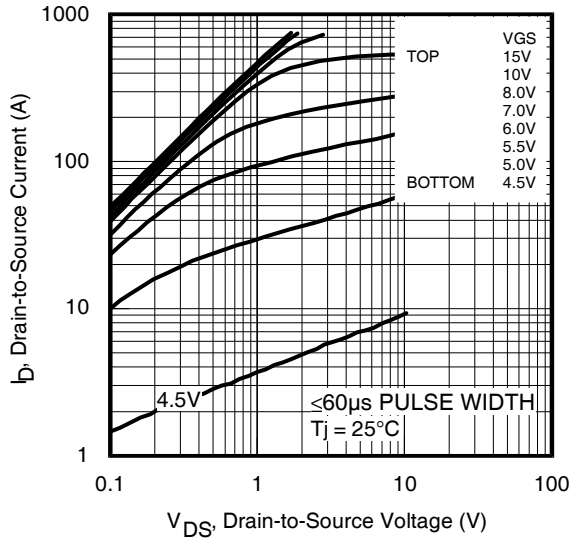
- ① Calculated continuous current based on maximum allowable junction temperature. Current is limited to 85A by source bond technology. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements. (Refer to AN-1140)
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.097\text{mH}$   
 $R_G = 50\Omega$ ,  $I_{AS} = 50\text{A}$ ,  $V_{GS} = 10\text{V}$ .
- ④  $I_{SD} \leq 50\text{A}$ ,  $di/dt \leq 1126\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$ .
- ⑤ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑥  $C_{oss}$  eff. (TR) is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑦  $C_{oss}$  eff. (ER) is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑧ When mounted on 1 inch square 2 oz copper pad on 1.5 x 1.5 in. board of FR-4 material.
- ⑨  $R_\theta$  is measured at  $T_J$  approximately  $90^\circ\text{C}$ .
- ⑩ Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 1\text{mH}$ ,  $R_G = 50\Omega$ ,  $I_{AS} = 22\text{A}$ ,  $V_{GS} = 10\text{V}$ .

Dynamic @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

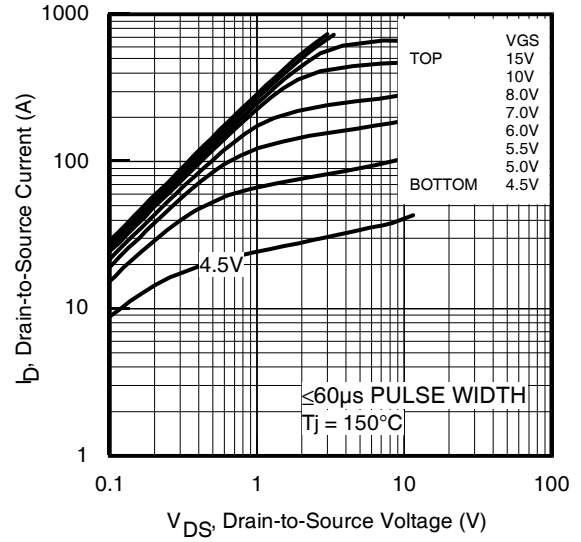
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
gfs	Forward Transconductance	149	—	—	S	$V_{DS} = 10\text{V}$ , $I_D = 50\text{A}$
$Q_g$	Total Gate Charge	—	92	138	nC	$I_D = 50\text{A}$ $V_{DS} = 20\text{V}$ $V_{GS} = 10\text{V}$ ⑤
$Q_{gs}$	Gate-to-Source Charge	—	22	—		
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	29	—		
$Q_{sync}$	Total Gate Charge Sync. ( $Q_g - Q_{gd}$ )	—	63	—		
$t_{d(on)}$	Turn-On Delay Time	—	12	—	ns	$V_{DD} = 20\text{V}$ $I_D = 30\text{A}$ $R_G = 2.7\Omega$ $V_{GS} = 10\text{V}$ ⑤
$t_r$	Rise Time	—	45	—		
$t_{d(off)}$	Turn-Off Delay Time	—	53	—		
$t_f$	Fall Time	—	42	—		
$C_{iss}$	Input Capacitance	—	4574	—	pF	$V_{GS} = 0\text{V}$ $V_{DS} = 25\text{V}$ $f = 1.0\text{MHz}$ $V_{GS} = 0\text{V}$ , $V_{DS} = 0\text{V}$ to $32\text{V}$ ⑦ $V_{GS} = 0\text{V}$ , $V_{DS} = 0\text{V}$ to $32\text{V}$ ⑥
$C_{oss}$	Output Capacitance	—	700	—		
$C_{rss}$	Reverse Transfer Capacitance	—	466	—		
$C_{oss}$ eff. (ER)	Effective Output Capacitance (Energy Related)	—	863	—		
$C_{oss}$ eff. (TR)	Effective Output Capacitance (Time Related)	—	1229	—		

Diode Characteristics

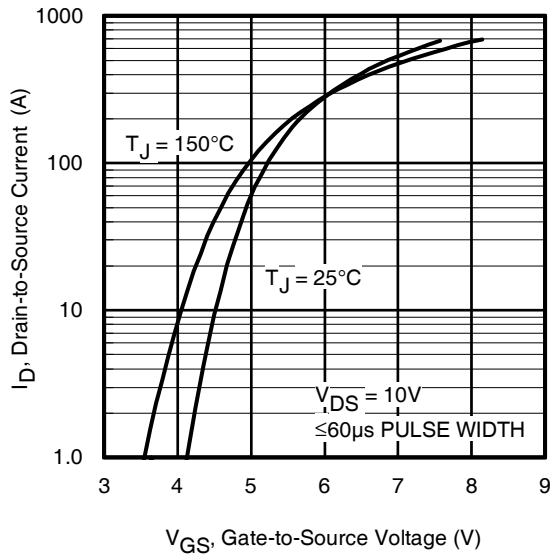
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	85 ①	A	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{SM}$	Pulsed Source Current (Body Diode) ②	—	—	745	A	
$V_{SD}$	Diode Forward Voltage	—	0.9	1.3	V	$T_J = 25^\circ\text{C}$ , $I_S = 50\text{A}$ , $V_{GS} = 0\text{V}$ ③
$t_{rr}$	Reverse Recovery Time	—	25	—	ns	$T_J = 25^\circ\text{C}$ $V_R = 34\text{V}$ , $T_J = 125^\circ\text{C}$ $I_F = 50\text{A}$
		—	27	—		
$Q_{rr}$	Reverse Recovery Charge	—	16	—	nC	$T_J = 25^\circ\text{C}$ $T_J = 125^\circ\text{C}$ $di/dt = 100\text{A}/\mu\text{s}$ ④
		—	17	—		
$I_{RRM}$	Reverse Recovery Current	—	1.2	—	A	$T_J = 25^\circ\text{C}$



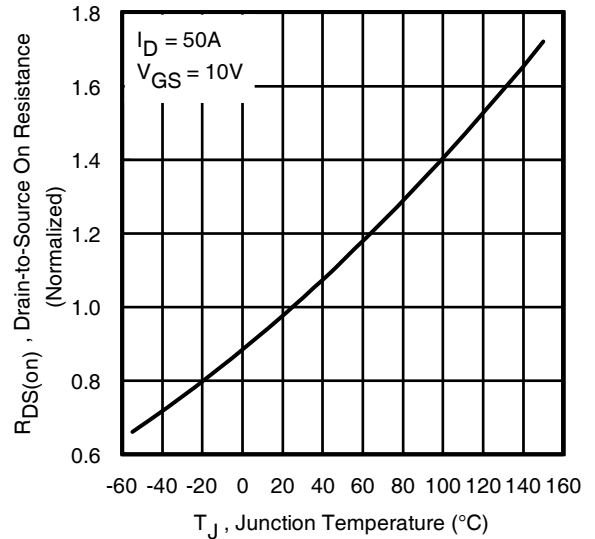
**Fig 3.** Typical Output Characteristics



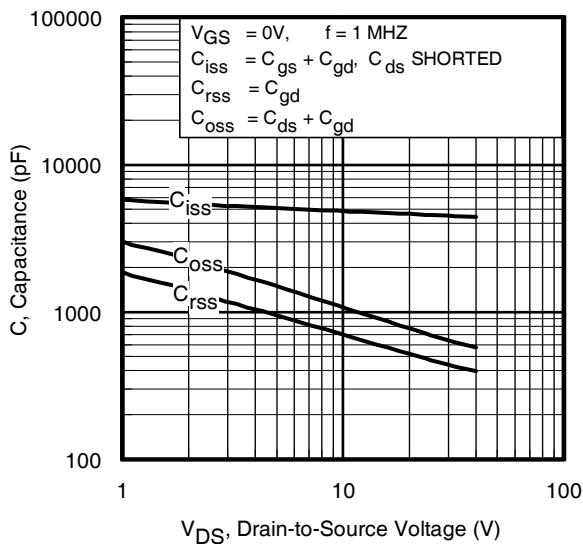
**Fig 4.** Typical Output Characteristics



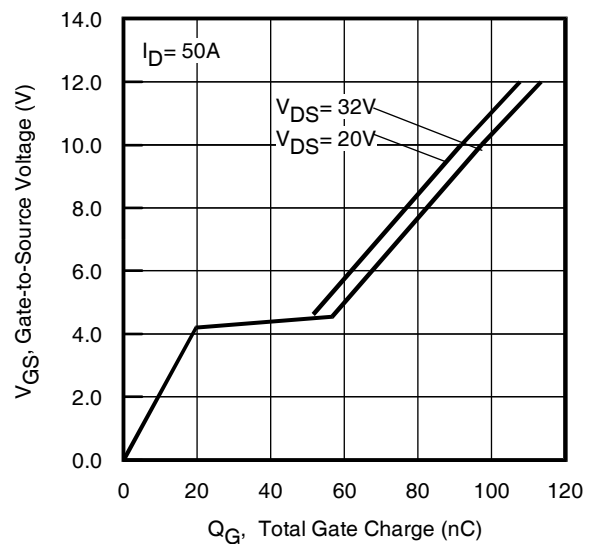
**Fig 5.** Typical Transfer Characteristics



**Fig 6.** Normalized On-Resistance vs. Temperature



**Fig 7.** Typical Capacitance vs. Drain-to-Source Voltage



**Fig 8.** Typical Gate Charge vs. Gate-to-Source Voltage

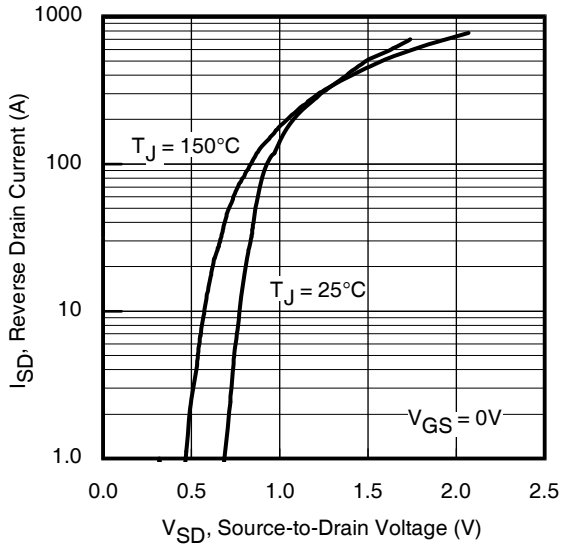


Fig 9. Typical Source-Drain Diode Forward Voltage

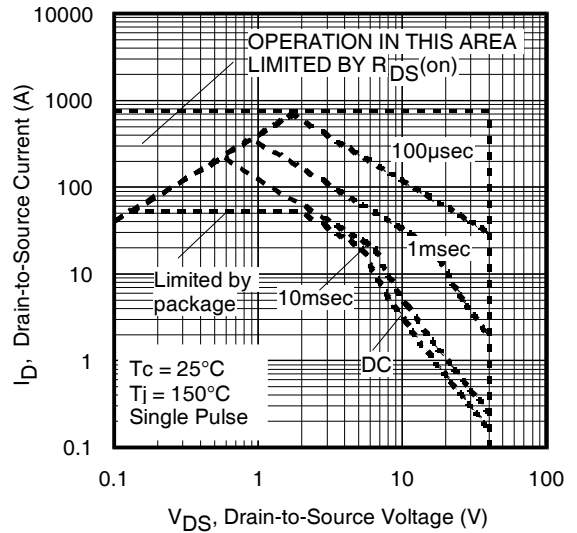


Fig 10. Maximum Safe Operating Area

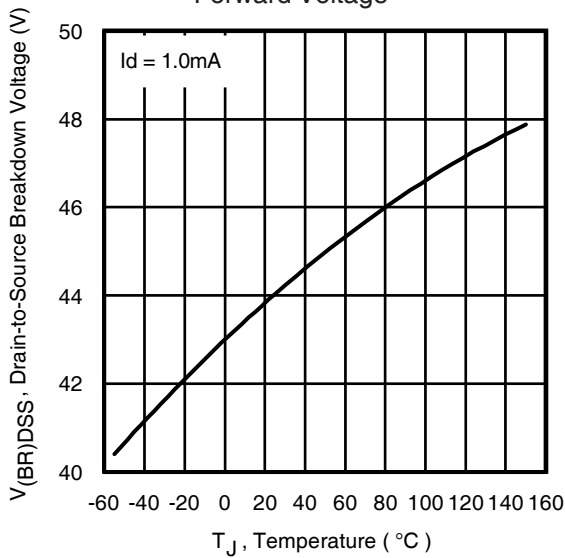


Fig 11. Drain-to-Source Breakdown Voltage

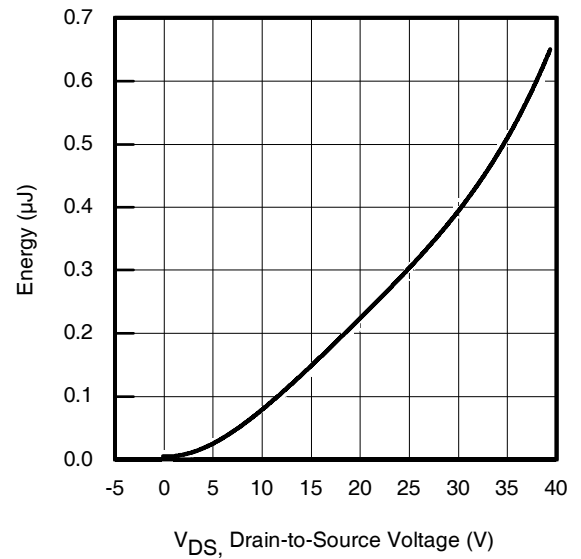
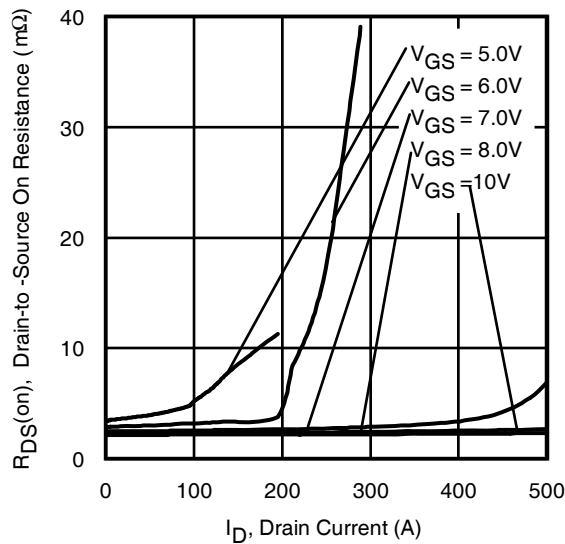


Fig 12. Typical  $C_{OSS}$  Stored Energy



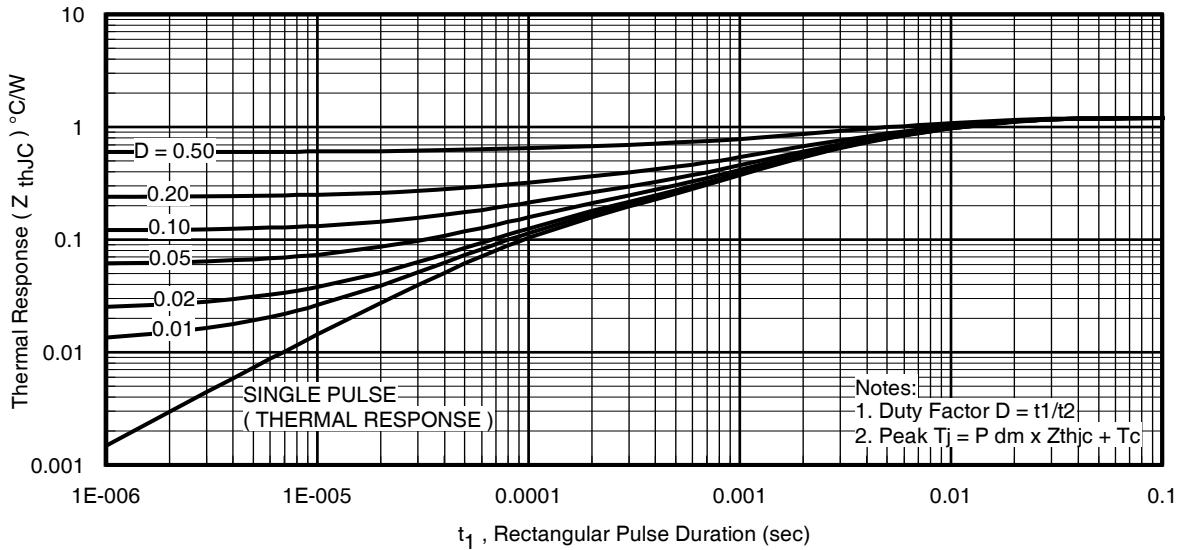


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

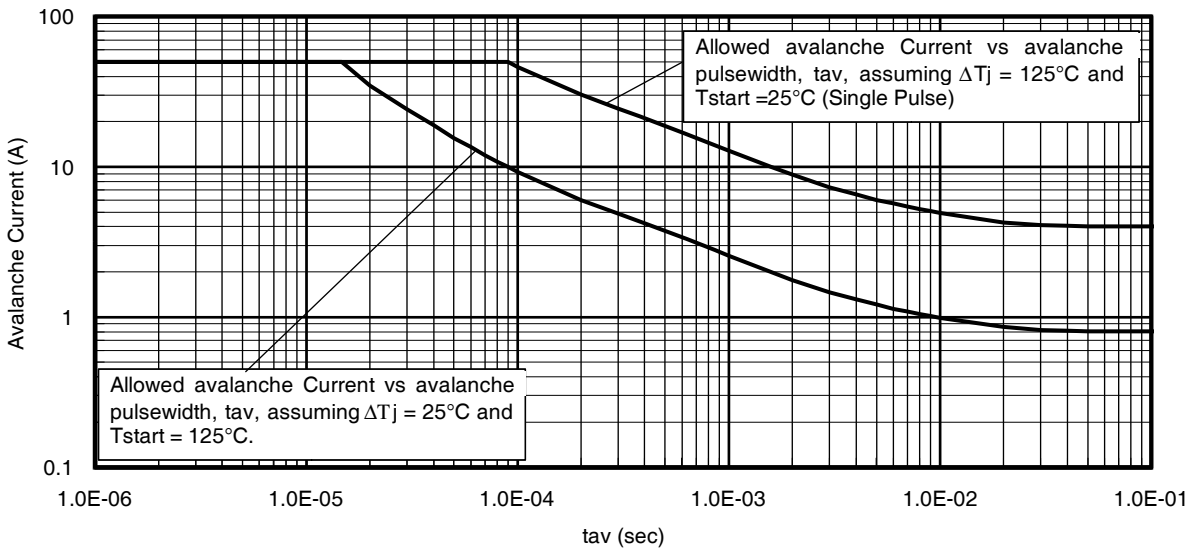


Fig 15. Typical Avalanche Current vs.Pulsewidth

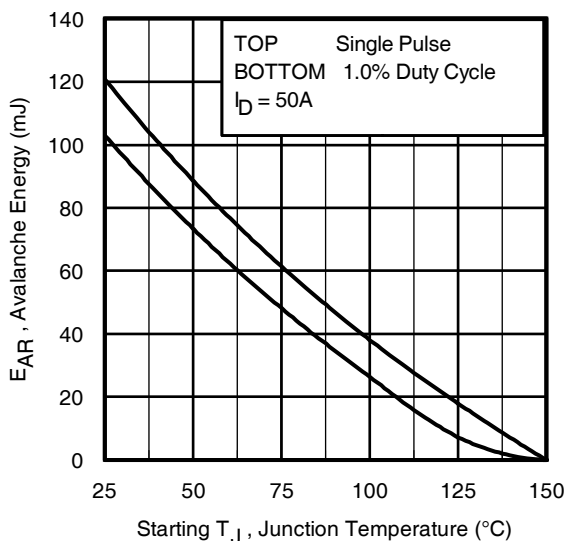


Fig 16. Maximum Avalanche Energy vs. Temperature

**Notes on Repetitive Avalanche Curves , Figures 14, 15:**  
(For further info, see AN-1005 at [www.irf.com](http://www.irf.com))

1. Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5.  $BV$  = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as  $25^{\circ}C$  in Figure 14, 15).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$P_{D(ave)} = 1/2 ( 1.3 \cdot BV \cdot I_{av} ) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

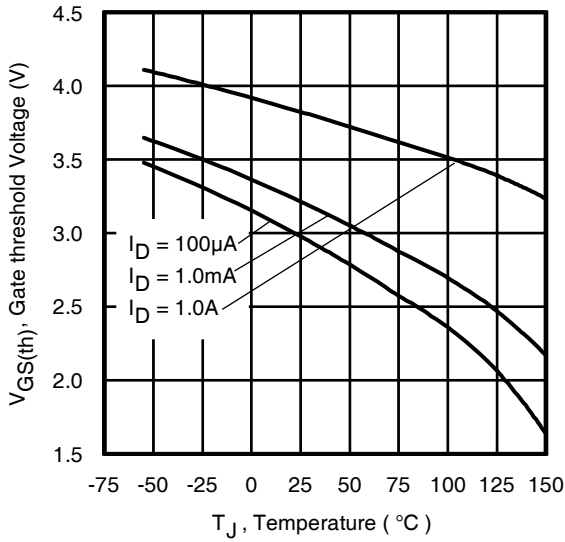


Fig 17. Threshold Voltage vs. Temperature

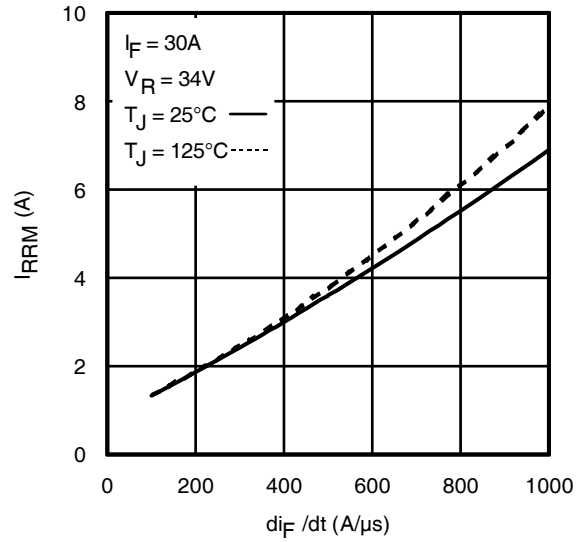


Fig. 18 - Typical Recovery Current vs.  $di_f/dt$

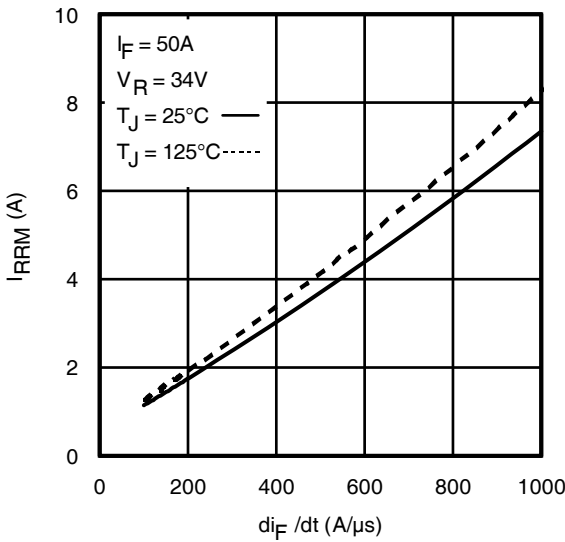


Fig. 19 - Typical Recovery Current vs.  $di_f/dt$

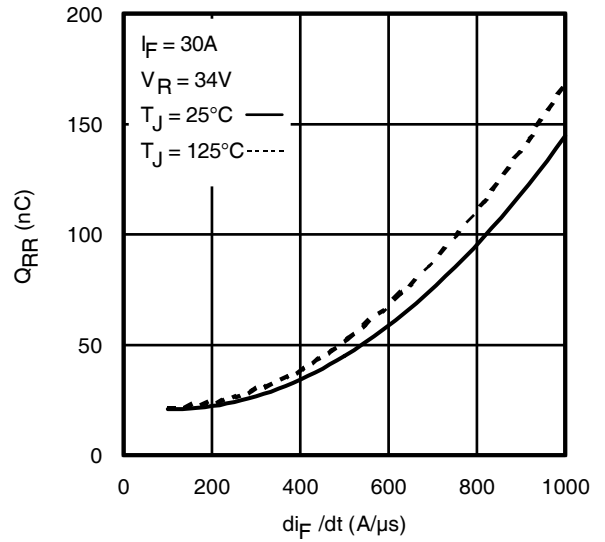


Fig. 20 - Typical Stored Charge vs.  $di_f/dt$

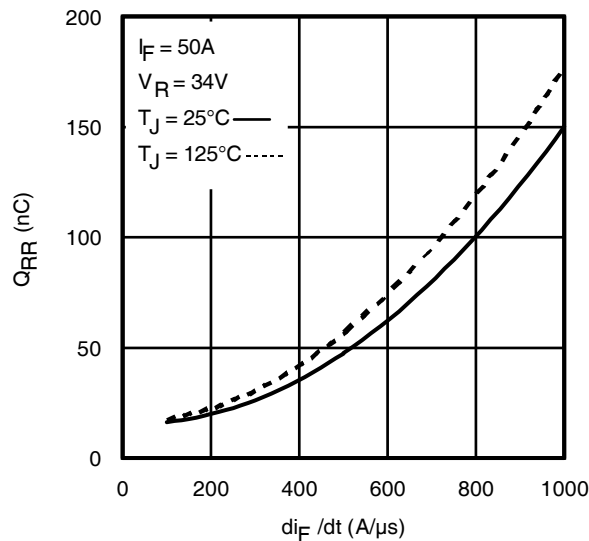
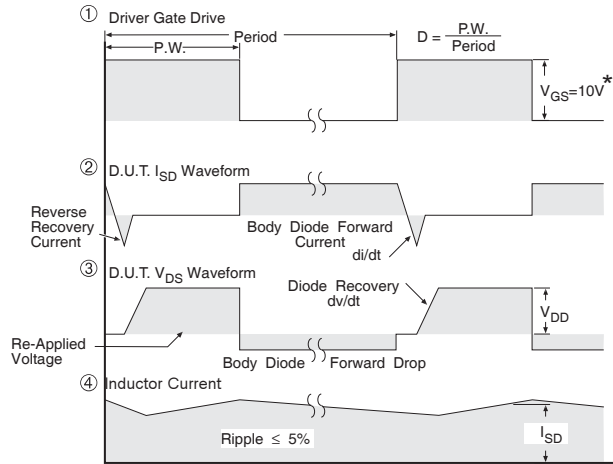
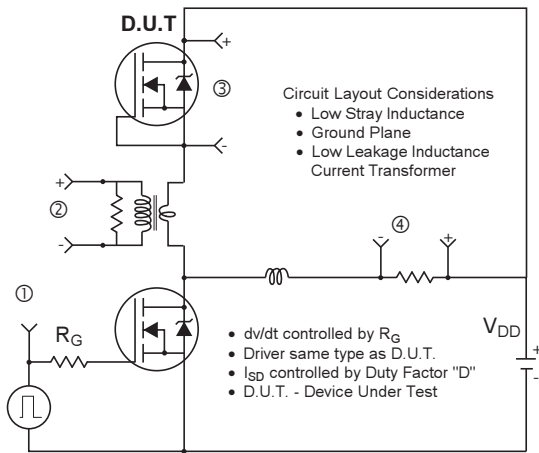
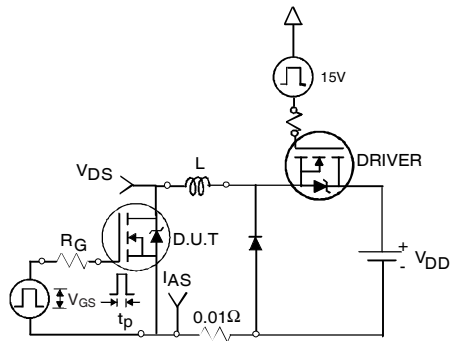


Fig. 21 - Typical Stored Charge vs.  $di_f/dt$

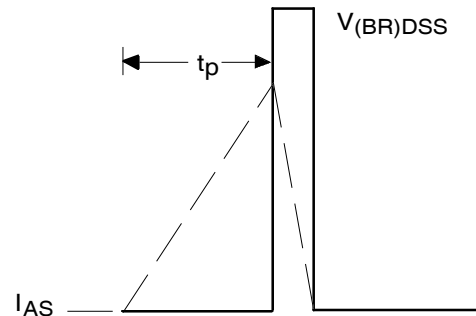


\*  $V_{GS} = 5V$  for Logic Level Devices

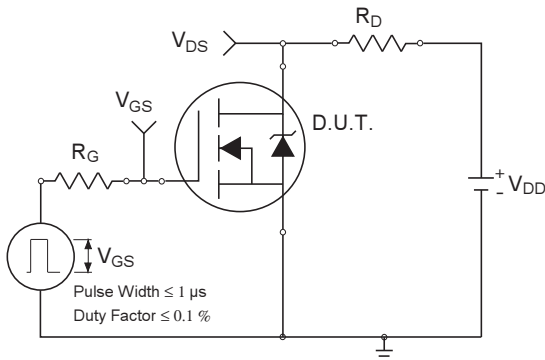
**Fig 22. Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET® Power MOSFETs**



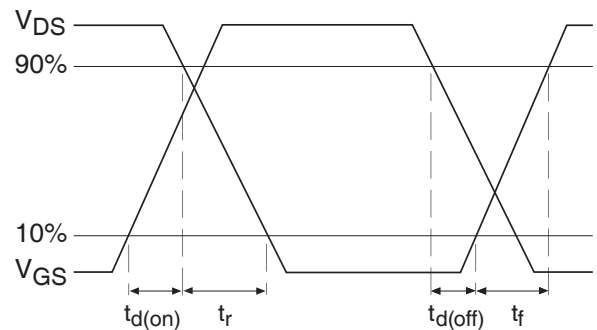
**Fig 22a. Unclamped Inductive Test Circuit**



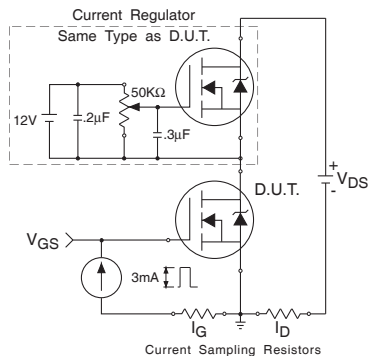
**Fig 22b. Unclamped Inductive Waveforms**



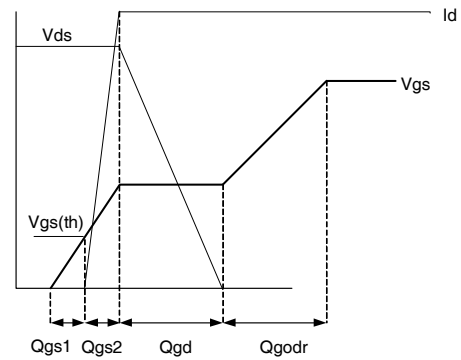
**Fig 23a. Switching Time Test Circuit**



**Fig 23b. Switching Time Waveforms**



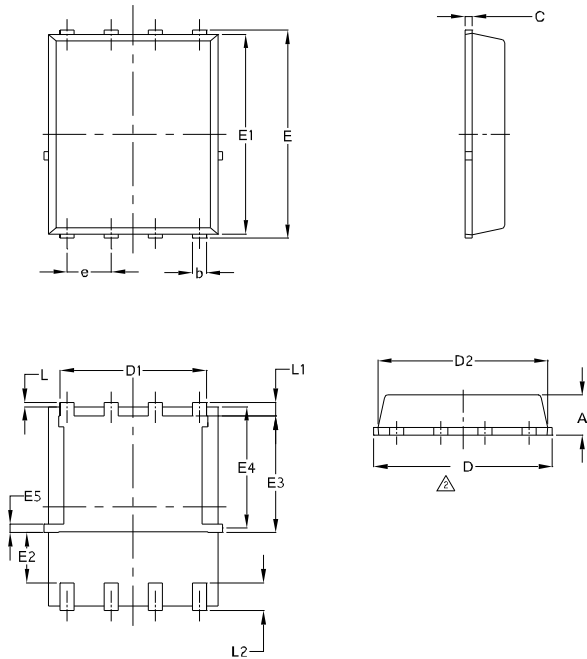
**Fig 24a. Gate Charge Test Circuit**



**Fig 24b. Gate Charge Waveform**

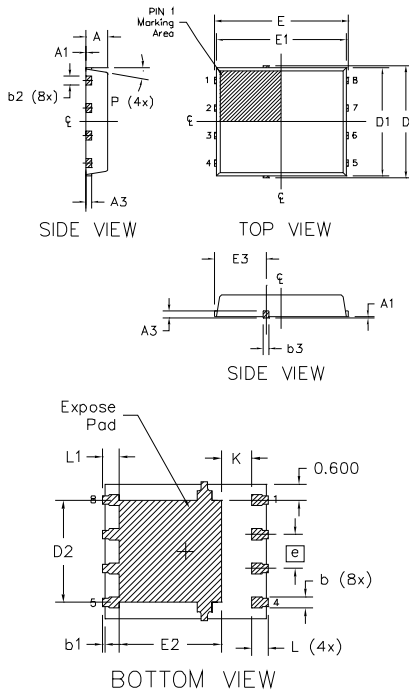


## PQFN 5x6 Outline "E" Package Details



SYMBOL	COMMON			
	MM		INCH	
	MIN.	MAX.	MIN.	MAX.
A	0.90	1.17	0.0354	0.0461
b	0.33	0.48	0.0130	0.0189
C	0.195	0.300	0.0077	0.0118
D	4.80	5.15	0.1890	0.2028
D1	3.91	4.31	0.1539	0.1697
D2	4.80	5.00	0.1890	0.1968
E	5.90	6.15	0.2323	0.2421
E1	5.65	6.00	0.2224	0.2362
E2	1.51	—	0.0594	—
E3	3.32	3.78	0.1307	0.1480
E4	3.42	3.58	0.1346	0.1409
E5	0.18	0.32	0.0071	0.0126
e	1.27	BSC	0.050	BSC
L	0.05	0.25	0.0020	0.0098
L1	0.38	0.66	0.0150	0.0260
L2	0.51	0.86	0.0201	0.0339
I	0	0.18	0	0.0071

## PQFN 5x6 Outline "G" Package Details

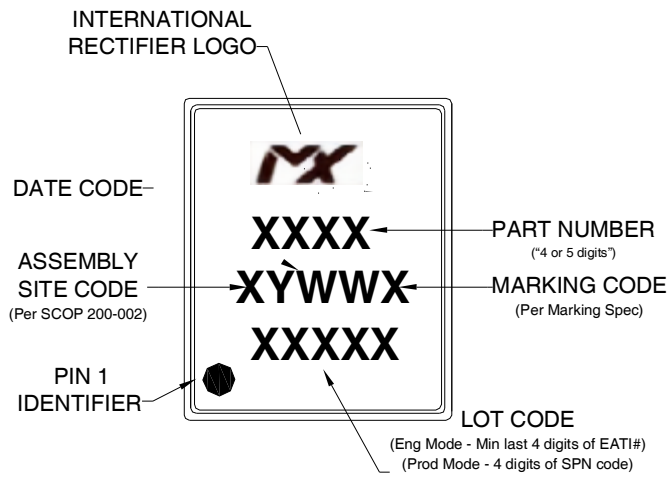


DIM SYMBOL	MILLIMETERS		INCH	
	MIN.	MAX.	MIN.	MAX.
A	0.950	1.050	0.0374	0.0413
A1	0.000	0.050	0.0000	0.0020
A3	0.254	REF	0.0100	REF
b	0.310	0.510	0.0122	0.0201
b1	0.025	0.125	0.0010	0.0049
b2	0.210	0.410	0.0083	0.0161
b3	0.180	0.450	0.0071	0.0177
D	5.150	BSC	0.2028	BSC
D1	5.000	BSC	0.1969	BSC
D2	3.700	3.900	0.1457	0.1535
E	6.150	BSC	0.2421	BSC
E1	6.000	BSC	0.2362	BSC
E2	3.560	3.760	0.1402	0.1488
E3	2.270	2.470	0.0894	0.0972
e	1.27	REF	0.050	REF
K	0.830	1.400	0.0327	0.0551
L	0.510	0.710	0.0201	0.0280
L1	0.510	0.710	0.0201	0.0280
P	10 deg	12 deg	0 deg	12 deg

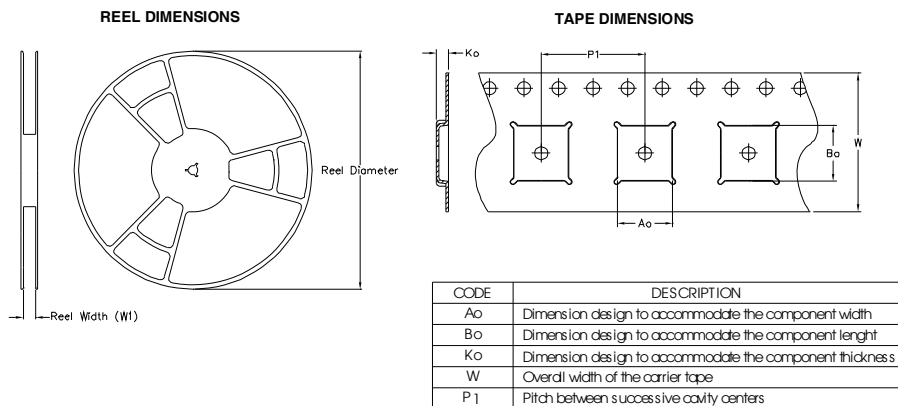
**Note:**

- Dimensions and tolerancing conform to ASME Y14.5M-1994
- Dimension L represents terminal full back from package edge up to 0.1mm is acceptable
- Coplanarity applies to the expose Heat Slug as well as the terminal
- Radius on terminal is Optional

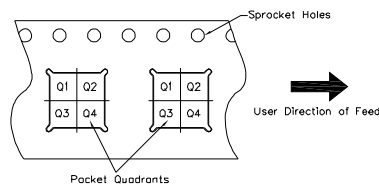
## PQFN 5x6 Part Marking



## PQFN 5x6 Tape and Reel



### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Note: All dimension are nominal

Package Type	Reel Diameter (Inch)	QTY	Reel Width W1 (mm)	Ao (mm)	Bo (mm)	Ko (mm)	P1 (mm)	W (mm)	Pin 1 Quadrant
5 X 6 PQFN	13	4000	12.4	6.300	5.300	1.20	8.00	12	Q1

**Qualification information<sup>†</sup>**

Qualification level	Industrial (per JEDEC JE S D47F guidelines) <sup>††</sup>	
Moisture Sensitivity Level	PQFN 5mm x 6mm	MSL1 (per JEDEC J-STD-020D <sup>††</sup> )
RoHS compliant	Yes	

**Revision History**

Date	Comment
1/13/2014	<ul style="list-style-type: none"> <li>Updated ordering information to reflect the End-Of-Life (EOL) of the mini-reel option (EOL notice #259).</li> <li>Updated data sheet with the new IR corporate template.</li> </ul>
2/19/2015	<ul style="list-style-type: none"> <li>Updated <math>E_{AS(L=1mH)} = 232mJ</math> on page 2</li> <li>Updated note 10 "Limited by <math>T_{Jmax}</math>, starting <math>T_J = 25^{\circ}C</math>, <math>L = 1mH</math>, <math>R_G = 50\Omega</math>, <math>I_{AS} = 22A</math>, <math>V_{GS} = 10V</math>". on page 2</li> </ul>
6/2/2015	<ul style="list-style-type: none"> <li>Updated package outline for "option E" and added package outline for "option G" on page 9.</li> <li>Updated "IFX" logo on page 1 &amp; 11.</li> <li>Updated tape and reel on page 10.</li> </ul>
7/7/2015	<ul style="list-style-type: none"> <li>Corrected package outline for "option E" on page 9.</li> </ul>